

14. TEST SETUP PHOTOGRAPHS

FCC ID: ZNFV30A		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1706070187-11.ZNF	Test Dates: 06/15/2017 - 07/10/2017	DUT Type: Portable Handset		Page 69 of 71

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Figure 14-1
Test Setup for Wireless Device

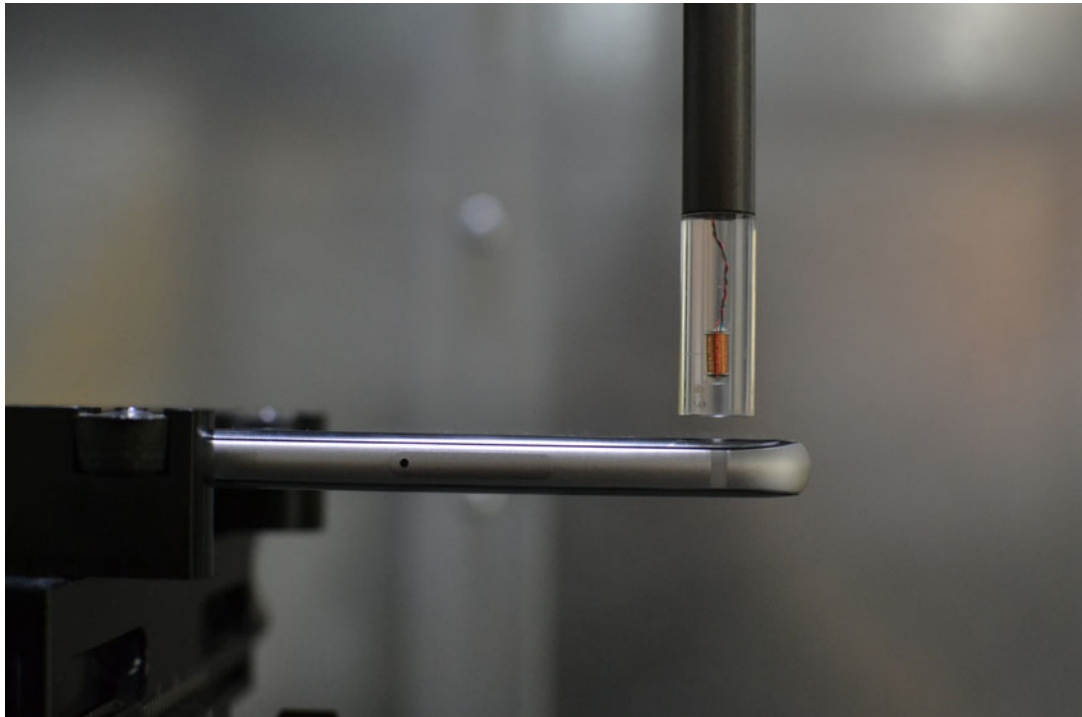


Figure 14-2
Test Setup for Wireless Device

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Figure 14-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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